TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC7WH241FU, TC7WH241FK

DUAL BUS BUFFER NON INVERTED, 3-STATE OUTPUTS

The TC7WH241 is an advanced high speed CMOS DUAL BUS BUFFERS fabricated with silicon gate CMOS technology.

They achieve the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The 7WH241 is an non-inverting 3-state buffer, and has two active-low output enables.

This device is designed to be used with 3-state memory address drivers, etc.

An input protection circuit ensures that 0 to 7V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V system and two supply system such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

FEATURES

MARKING

SM8

•	High	Speed	 $t_{pd} = 3.9$ ns (Typ.)	at
			$\dot{V}_{CC} = 5V$	

- Low Power Dissipation $I_{CC} = 2\mu A$ (Max.) at
- High Noise Immunity ······· V_{NIH} = V_{NIL} = 28% V_{CC} (Min.)
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays $\cdots t_{pLH} = t_{pHL}$

Type Name

- Wide Operation Voltage Range $\sim V_{CC}$ (opr) = 2~5.5V

US8

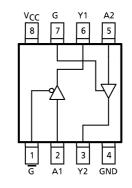
пппп WН 241



SSOP8-P-0.65 : 0.02g (Typ.)

SSOP8-P-0.50A : 0.01g (Typ.)

Weight



PIN ASSIGNMENT (TOP VIEW)

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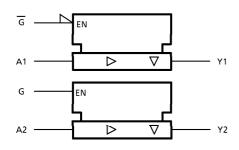
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TOSHIBA TC7WH241FU/FK

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT			
Supply Voltage Range	V _{CC}	-0.5~7.0	V			
DC Input Voltage	VIN	-0.5~7.0	V			
DC Output Voltage	Vout	-0.5~V _{CC} +0.5	٧			
Input Diode Current	lικ	- 20	mA			
Output Diode Current	lok	± 20	mA			
DC Output Current	lout	± 25	mA			
DC V _{CC} /Ground Current	lcc	± 50	mA			
Bewer Dissinction	D-	300 (SM8)				
Power Dissipation	PD	200 (US8)	mW			
Storage Temperature	T _{stg}	-65∼150	°C			
Lead Temperature (10 s)	TL	260	°C			

LOGIC DIAGRAM



TRUTH TABLE

	INPUTS	OUTPUTS	
G	G	Υ	
L	H	F	L
L	Н	Н	Н
Н	L	×	Z

x : Don't Care Z : High Impedance

RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Supply Voltage	Vcc	2~5.5	V	
Input Voltage	V _{IN}	0~5.5	V	
Output Voltage	Vout	0~V _{CC}	V	
Operating Temperature	T _{opr}	- 40∼85	°C	
Input Rise and Fall Time	dt/dv	$0\sim100 \text{ (V}_{CC} = 3.3 \pm 0.3 \text{V)}$	ns / V	
Imput Rise and Fan Time	at/av	$0\sim20 \ (V_{CC} = 5 \pm 0.5V)$	115 / V	

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DC ELECTRICAL CHARACTERISTICS

		TEST CONDITION		IV	Ta = 25°C			$Ta = -40 \sim 85^{\circ}C$			
CHARACTERISTIC	SYMBOL			Vcc (V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT	
High-Level				2.0	1.5	_	_	1.5	_		
Input Voltage	V _{IH}		_	3.0~ 5.5	V _{CC} ×0.7	_	_	V _C C ×0.7	-	V	
Low-Level				2.0	_		0.5	_	0.5		
Input Voltage	V _{IL}		_ [3.0~ 5.5		-	V _C C × 0.3	_	V _C C × 0.3	V	
			I _{OH} = -50μA	2.0	1.9	2.0	_	1.9	_	V	
High-Level		$V_{IN} = V_{IH}$		3.0	2.9	3.0	_	2.9	_		
Output Voltage	VOH	or V _{IL}		4.5	4.4	4.5	_	4.4	_		
Output Voltage			$I_{OH} = -4mA$	3.0	2.58	1	_	2.48	_		
			$I_{OH} = -8mA$	4.5	3.94		_	3.8	_		
		V _{IN} = V _{IL}	I _{OL} = 50μA	2.0	_	0.0	0.1	_	0.1	V	
Low-Level				3.0	_	0.0	0.1	_	0.1		
Output Voltage	VOL			4.5	_	0.0	0.1	_	0.1		
Catput Voltage			$I_{OL} = 4mA$	3.0	_		0.36	_	0.44		
			$I_{OL} = 8mA$	4.5	_	_	0.36	_	0.44		
3-State Output Off-State Current	loz	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		5.5		-	± 0.25	_	± 2.5	μ A	
Input Leakage Current	IN	V _{IN} = V _{CC} or GND		0~ 5.5	_	_	±0.1	_	± 1.0	μΑ	
Quiescent Supply Current	lcc	V _{IN} = V _{CC} or GND		5.5	_	_	2.0	_	20.0	μΑ	

AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3ns$)

CHADACTERISTIC	SYMBOL	TEST C	CONDITION		٦	Ta = 25°C		Ta = -40~85°C		UNIT
CHARACTERISTIC	STIVIBUL	V _{CC} (V) (C _L (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
			3.3 ± 0.3	15		5.3	7.5	1.0	9.0	ns
Propagation Delay	^t pLH			50	_	7.8	11.0	1.0	12.5	
Time	tpHL		5.0 ± 0.5	15		3.6	5.5	1.0	6.5	
			3.0 ± 0.5	50	_	5.1	7.5	1.0	8.5	
			3.3 ± 0.3	15		6.6	10.6	1.0	12.5	- ns
3-State Output	^t pZL ^t pZH	$R_L = 1k\Omega$		50	_	9.1	14.1	1.0	16.0	
Enable Time			5.0 ± 0.5	15	_	4.7	7.3	1.0	8.5	
				50	_	6.2	9.3	1.0	10.5	
3-State Output	^t pLZ		3.3 ± 0.3	50	_	10.3	14.0	1.0	16.0	nc
Disable Time	t _{pHZ}		5.0 ± 0.5	50	_	6.7	9.2	1.0	10.5	ns
Output to Output	tosLH	(Note 1)	3.3 ± 0.3	50	_	_	1.5	_	1.5	25
Skew	tosHL	(Note I)	5.0 ± 0.5	50	_	_	1.0	_	1.0	ns
Input Capacitance	CIN				_	4	10	_	10	рF
Output Capacitance	COUT					6				pF
Power Dissipation Capacitance (Note 2)	C _{PD}				_	17	_	_	_	pF

(Note 1) : Parameter guaranteed by design. $t_{OSLH} = |t_{pLHm} - t_{pLHn}| \cdot t_{OSHL} = |t_{pHLm} - t_{pHLn}|$ (Note 2) : CpD is defined as the value of the internal equivalent capacitance which is

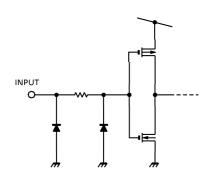
calculated from the operating current consumption without load. Average operating current can be obtained by the equation :

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 2$ (per bit)

NOISE CHARACTERISTICS (Ta = 25°C, Input $t_r = t_f = 3$ ns)

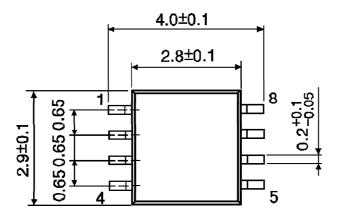
CHARACTERISTIC	SYMBOL	TEST CONDITION	V _{CC} (V)	TYP.	LIMIT	UNIT
Quiet Output Maximum Dynamic V _{OL}	V _{OLP}	C _L = 50pF	5.0	0.5	0.8	V
Quiet Output Minimum Dynamic V _{OL}	V _{OLV}	C _L = 50pF	5.0	- 0.5	-0.8	V
Minimum High Level Dynamic Input Voltage	V _{IHD}	C _L = 50pF	5.0	_	3.5	٧
Maximum Low Level Dynamic Input Voltage	V _{ILD}	C _L = 50pF	5.0	_	1.5	V

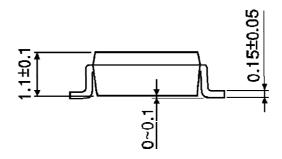
INPUT EQUIVALENT CIRCUIT



OUTLINE DRAWING SSOP8-P-0.65

Unit: mm

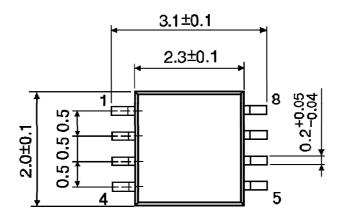


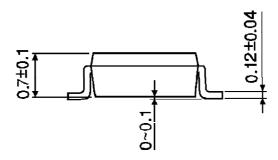


Weight: 0.02g (Typ.)

OUTLINE DRAWING SSOP8-P-0.50A

Unit: mm





Weight: 0.01g (Typ.)